

# SJTU04N70C

Lead Free Package and Finish

# Super-Junction MOSFET

# **Applications:**

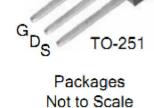
- Adaptor
- Charger
- •SMPS

# Features:

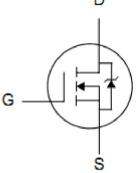
- RoHS Compliant
- Low ON Resistance
- •Low Gate Charge
- Peak Current vs Pulse Width Curve
- Inductive Switching Curves

# **Ordering Information**

V <sub>DSS</sub>	R <sub>DS(ON)</sub> (Typ.)	I <sub>D</sub>			
700V	700V 1.15Ω				



Pb



PART NUMBERPACKAGEBRANDSJTU04N70CTO-251IPS

## Absolute Maximum Ratings T<sub>C</sub>=25<sup>°</sup>C unless otherwise specified

Symbol	Parameter	SJTU04N70C	Units
V <sub>DSS</sub>	Drain-to-Source Voltage	700	V
I <sub>D</sub>	Continuous Drain Current	4	Α
I <sub>DM</sub>	Pulsed Drain Current, V <sub>GS</sub> @10V (NOTE *2)	12	Α
П	Power Dissipation	36.8	W
P <sub>D</sub>	Derating Factor above 25 °C	0.29	W/°C
V <sub>GS</sub>	Gate-to-Source Voltage	±30	V
E <sub>AS</sub>	Single Pulse Avalanche Energy(L=10mH)	20	mJ
E <sub>AR</sub>	Avalanche Energy ,Repetitive (NOTE *2)	0.09	mJ
I <sub>AR</sub>	Avalanche Current (NOTE *2)	2	Α
TL	Maximum Temperature for Soldering	300	
$T_{\rm J}$ and $T_{\rm STG}$	Operating Junction and Storage Temperature Range (NOTE *1)	150,-55 to150	°C

#### Thermal Resistance

Symbol	Parameter	Тур.	Units	Test Conditions
Б	Junction-to-Case 3.4 °C/W	3.4 °C <i>X</i> W		Water cooled heatsink, $P_{D}$ adjusted for a
$R_{ extsf{ heta}JC}$				1011-10-Case 5.4 °CM
R <sub>0JA</sub>	Junction-to-Ambient	75		1 cubic foot chamber, free air.

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## **OFF Characteristics** $T_C=25^{\circ}C$ unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
BV <sub>DSS</sub>	Drain-to-Source Breakdown Voltage	700			V	V <sub>GS</sub> =0V, I <sub>D</sub> =250µA
I <sub>DSS</sub>	Drain-to-Source Leakage Current			1		V <sub>DS</sub> =700V, V <sub>GS</sub> =0V T <sub>J</sub> =25℃
				100	μA	V <sub>DS</sub> =700V, V <sub>GS</sub> =0V TJ=150℃
I <sub>GSS</sub>	Gate-to-Source Forward Leakage		+100	<b>n</b> 4	V <sub>GS</sub> =+30V	
	Gate-to-Source Reverse Leakage			-100	- nA	V <sub>GS</sub> = -30V

**ON Characteristics**  $T_J=25^{\circ}C$  unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
R <sub>DS(ON)</sub>	StaticDrain-to-Source		1.15	1 25	Ω	V <sub>GS</sub> =10V, I <sub>D</sub> =1A
	On-Resistance(NOTE *3)			1.35		
V <sub>GS(TH)</sub>	Gate Threshold Voltage	2.5		4	V	$V_{DS}=V_{GS}$ , $I_{D}=250\mu A$
<b>g</b> <sub>fs</sub>	Forward Transconductance(NOTE *3)		3		S	V <sub>DS</sub> =10V, I <sub>D</sub> =1A

Dynamic Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
C <sub>iss</sub>	Input Capacitance		350		pF	V <sub>GS</sub> = 0V,V <sub>DS</sub> = 50V f =1.0MHz
C <sub>oss</sub>	Output Capacitance		40			
C <sub>rss</sub>	Reverse Transfer Capacitance		3.5			
Qg	Total Gate Charge		7		nC	I <sub>D</sub> =1.5A,V <sub>DD</sub> =560V V <sub>GS</sub> = 10V
Q <sub>gs</sub>	Gate-to-Source Charge		1.5			
$Q_{gd}$	Gate-to-Drain ("Miller") Charge		2.5			

# Resistive Switching Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
t <sub>d(ON)</sub>	Turn-on Delay Time		7.7		- ns	$V_{DD}$ =400V, I <sub>D</sub> =1.5A, V <sub>G</sub> =10V R <sub>G</sub> =25Ω
t <sub>rise</sub>	Rise Time		5.9			
t <sub>d(OFF)</sub>	Turn-Off Delay Time		33			
t <sub>fall</sub>	Fall Time		18.2			

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Source-Drain Dioue Characteristics 10-20		. <b>J</b> C u	11033 (		ise spe	cilieu
Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
	Continuous Source Current			2.8	А	
IS	(Body Diode)			2.0	A	T <sub>c</sub> =25℃
	Maximum Pulsed Current			8.3	А	1 <sub>C</sub> -25 C
I <sub>SM</sub>	(Body Diode)			0.3	A	
V <sub>SD</sub>	Diode Forward Voltage			1.2	V	I <sub>SD</sub> =1.5A, V <sub>GS</sub> =0V
t <sub>rr</sub>	Reverse Recovery Time		220		ns	I <sub>F</sub> = I <sub>S</sub>
Q <sub>rr</sub>	Reverse Recovery Charge		0.9		uC	di/dt=100A/us

#### Source-Drain Diode Characteristics Tc=25%

Tc=25<sup>°</sup>C unless otherwise specified

Notes:

\*1. T<sub>J</sub> = +25℃ to +150℃.

\*2. Repetitive rating; pulse width limited by maximum junction temperature.

\*3. Pulse width <  $380\mu$ s; duty cycle < 2%.



#### **Characteristics Curve:**

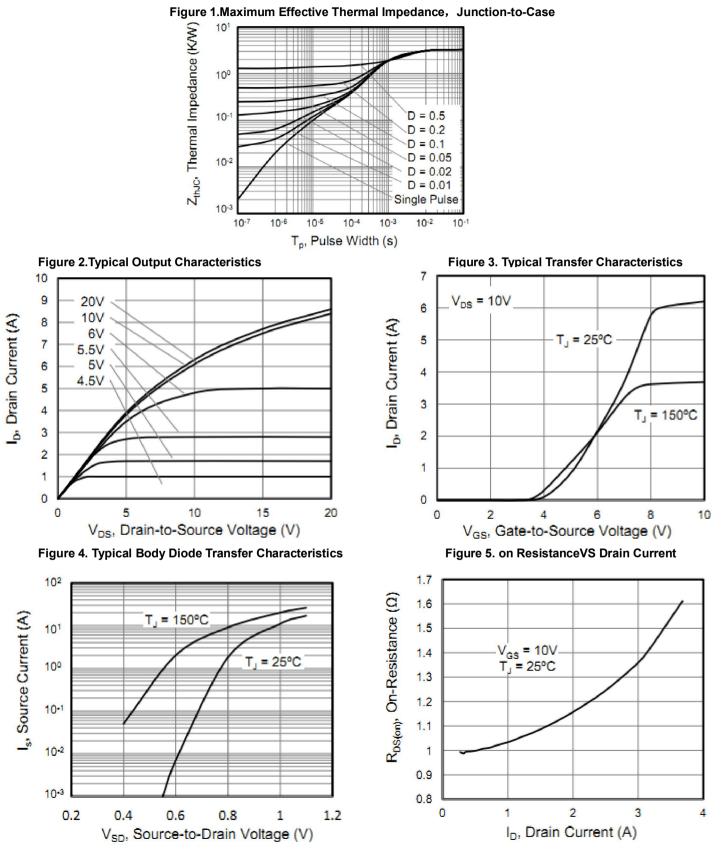
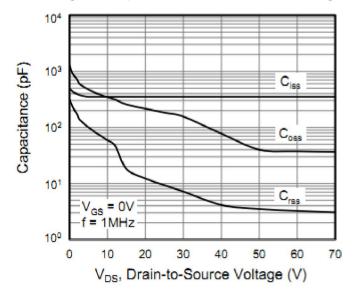




Figure 6. Capacitance VS Drain-to-Source Voltage

Figure 7. Gate Charge VS Gate-to-Source Voltage



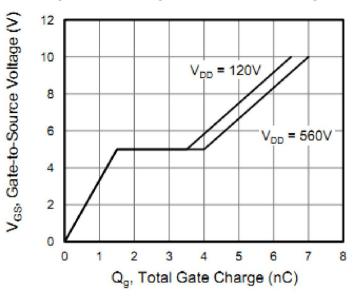


Figure 8. Threshold Voltage VS Temperature

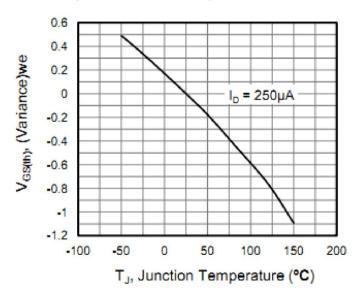
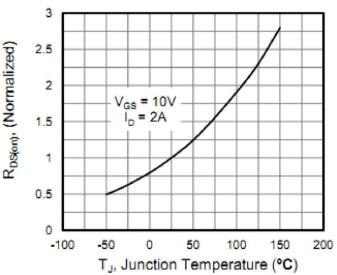


Figure 9. on-Resistance VS Temperature





# **Test Circuits and Waveforms**

#### Figure 11. Gate Charge Test Circuit

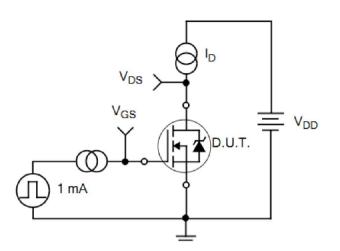


Figure 12. Gate Charge Waveforms

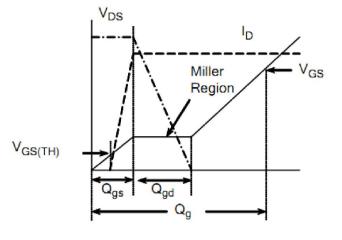
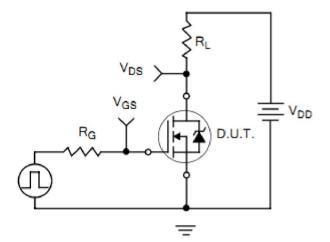
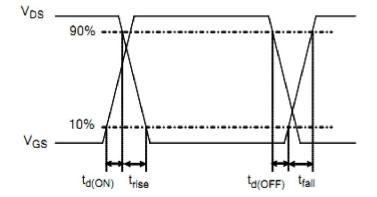


Figure 13. Resistive Switching Test Circuit

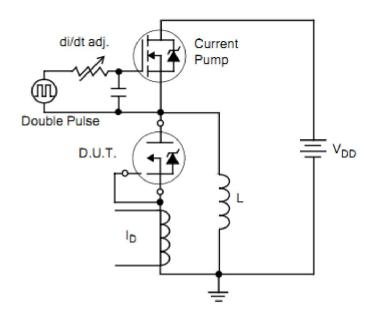








#### Figure 15. Diode Reverse Recovery Test Circuit



#### Figure 16. Diode Reverse Recovery Waveform

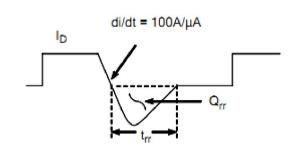


Figure17.Unclamped Inductive Switching Test Circuit

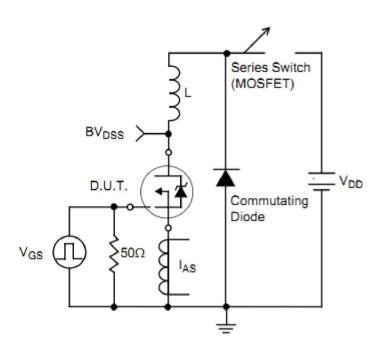
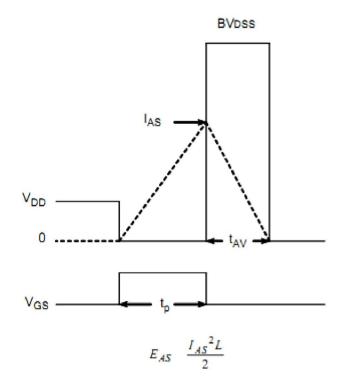


Figure18.Unclamped Inductive Switching Waveform





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